

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10597518	NAKAHARA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Kwang Han	1795

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Search	3/24/2009	KH
Text search of class 429/231.95	3/24/2009	KH
See EAST search notes	3/24/2009	KH
STIC search from 10/597517	11/6/2009	KH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

--	--